Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/537,492	OHASHI ET AL.	
Examiner	Art Unit	
K. Richard Lee	2832	

	SEARCHED		
Class	Subclass	Date	Examiner
338	20-25	10/29/2007	KL
			·,
			···

, INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			,
٧			
	1		

•	DATE	EXMR
	i	